Product Preview

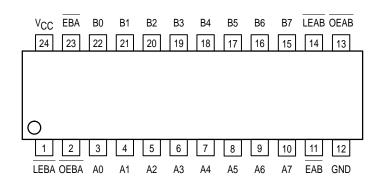
Low-Voltage CMOS Octal Latching Transceiver With 5V-Tolerant Inputs and Outputs (3-State, Non-Inverting)

The MC74LCX543 is a high performance, non–inverting octal latching transceiver operating from a 2.7 to 3.6V supply. High impedance TTL compatible inputs significantly reduce current loading to input drivers while TTL compatible outputs offer improved switching noise performance. A V_I specification of 5.5V allows MC74LCX543 inputs to be safely driven from 5V devices. The MC74LCX543 is suitable for memory address driving and all TTL level bus oriented transceiver applications.

For data flow from A to B with the EAB LOW, the A-to-B Output Enable (OEAB) must be LOW in order to enable data to the B bus, as indicated in the Function Table. With EAB LOW, a LOW signal on the A-to-B Latch Enable (LEAB) input makes the A-to-B latches transparent; a subsequent LOW-to-HIGH transition of the LEAB signal will latch the A latches, and the outputs no longer change with the A inputs. With EAB and OEAB both LOW, the 3-State B output buffers are active and reflect the data present at the output of the A latches. Control of data flow from B to A is symetric to that above, but uses the EBA, LEBA, and OEBA inputs.

- Designed for 2.7 to 3.6V VCC Operation
- 5V Tolerant Interface Capability With 5V TTL Logic
- Supports Live Insertion and Withdrawal
- I_{OFF} Specification Guarantees High Impedance When V_{CC} = 0V
- LVTTL Compatible
- LVCMOS Compatible
- 24mA Balanced Output Sink and Source Capability
- Near Zero Static Supply Current in All Three Logic States (10μA) Substantially Reduces System Power Requirements
- Latchup Performance Exceeds 500mA
- ESD Performance: Human Body Model >2000V; Machine Model >200V

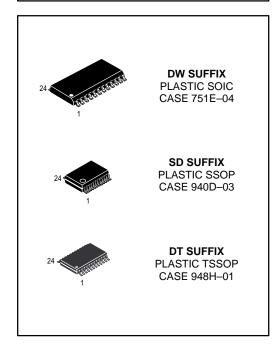
Pinout: 24-Lead Package (Top View)



MC74LCX543



LOW-VOLTAGE CMOS OCTAL LATCHING TRANSCEIVER



PIN NAMES

Pins	Function
OExx Exx LExx A0-A7 B0-B7	Output Enable Inputs Enable Inputs Latch Enable Inputs 3-State Inputs/Outputs 3-State Inputs/Outputs

This document contains information on a product under development. Motorola reserves the right to change or discontinue this product without notice.





DETAIL A X 7 OEBA 2 OEBA 23 OEBA 24 OEBA 24 OEBA 24 OEBA 25 OEBA 25

FUNCTION TABLE

			Inp	uts					rnal tch	Out	puts	
An	OEAB	EAB	LEAB	Bn	OEBA	EBA	LEBA	QABn	QBAn	A0-A7	B0-B7	Operating Mode
h I	L L	L L	$\uparrow \\ \uparrow$	CC	H	X X	X X	H L	X X	NA NA	H L	Latch & Display B Outputs
Х	L	L	Н	O	Н	Х	Х	NC	Х	NA	NC	Hold, Read B Outputs
h – h –	LLII	↑	L L↑	X X X	ннн	X X X	X X X	HLHL	H L X X	NA NA NA NA	Z Z Z Z	Latch and B Outputs Disabled
H	L L	L L	L L	U	H	X X	X X	H L	X X	NA NA	H	Transparent A to B
X X	H X	X H	X X	X	ΗH	X X	X X	X NC	X X	NA NA	Z Z	Disable B Outputs
U	ΙΙ	X X	X X	h I		LL	$\uparrow \\ \uparrow$	X X	H L	H L	NA NA	Latch & Display A Outputs
U	Н	Х	Х	Х	L	L	Н	Х	NC	NC	NA	Hold, Read A Outputs
X X X	IIII	X X X	X X X	h – h –		←← ∟ ∟	LI LI↑↑	H L X	HLHL	Z Z Z Z	NA NA NA NA	Latch and A Outputs Disabled
U	HH	X X	X X	X L	L	L L	L L	X X	H L	H L	NA NA	Transparent B to A
X	ΗH	X X	X X	X	H X	X H	X X	X X	X NC	Z Z	NA NA	Enable A Outputs

H = High Voltage Level; h = High Voltage Level One Setup Time Prior to the Latch Enable or Enable Low–to–High Transition; L = Low Voltage Level; I = Low Voltage Level One Setup Time Prior to the Latch Enable or Enable Low–to–High Transition; Z = High Impedance State; X = High or Low Voltage Level and Transitions are Acceptable; NC = No Change; ↑ = Low–to–High Transition; U = Undriven

ABSOLUTE MAXIMUM RATINGS*

Symbol	Parameter	Value	Condition	Unit
VCC	DC Supply Voltage	-0.5 to +7.0		V
VI	DC Input Voltage	$-0.5 \le V_1 \le +7.0$		V
VO	DC Output Voltage	$-0.5 \le V_{O} \le +7.0$	Output in 3–State	V
		$-0.5 \le V_O \le V_{CC} + 0.51$	Output in HIGH or LOW State	V
IIK	DC Input Diode Current	-50	V _I < GND	mA
loк	DC Output Diode Current	-50	V _O < GND	mA
		+50	AO > ACC	mA
IO	DC Output Source/Sink Current	±50		mA
Icc	DC Supply Current Per Supply Pin	±100		mA
IGND	DC Ground Current Per Ground Pin	±100		mA
T _{STG}	Storage Temperature Range	-65 to +150		°C

Absolute maximum continuous ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute–maximum–rated conditions is not implied.

1. IO absolute maximum rating must be observed.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Тур	Max	Unit
VCC	Supply Voltage Operating Data Retention Only	2.0 1.5	3.3 3.3	3.6 3.6	V
VI	Input Voltage	0		5.5	V
Vo	Output Voltage (HIGH or LOW State) (3–State)	0 0		V _{CC} 5.5	V
IOH	HIGH Level Output Current, V _{CC} = 3.0V – 3.6V			-24	mA
loL	LOW Level Output Current, V _{CC} = 3.0V – 3.6V			24	mA
^I ОН	HIGH Level Output Current, V _{CC} = 2.7V - 3.0V			-12	mA
loL	LOW Level Output Current, V _{CC} = 2.7V – 3.0V			12	mA
T _A	Operating Free–Air Temperature	-40		+85	°C
Δt/ΔV	Input Transition Rise or Fall Rate, V_{IN} from 0.8V to 2.0V, $V_{CC} = 3.0V$	0		10	ns/V

DC ELECTRICAL CHARACTERISTICS

			T _A = -40°C	to +85°C	
Symbol	Characteristic	Condition	Min	Max	Unit
VIH	HIGH Level Input Voltage (Note 1)	$2.7V \le V_{CC} \le 3.6V$	2.0		V
V _{IL}	LOW Level Input Voltage (Note 1)	$2.7V \le V_{CC} \le 3.6V$		0.8	V
Vон	HIGH Level Output Voltage	$2.7V \le V_{CC} \le 3.6V; I_{OH} = -100\mu A$	V _{CC} – 0.2		V
		$V_{CC} = 2.7V; I_{OH} = -12mA$	2.2		
		$V_{CC} = 3.0V; I_{OH} = -18mA$	2.4		
		$V_{CC} = 3.0V; I_{OH} = -24mA$	2.2		
VOL	LOW Level Output Voltage	$2.7V \le V_{CC} \le 3.6V; I_{OL} = 100\mu A$		0.2	V
		V _{CC} = 2.7V; I _{OL} = 12mA		0.4	
		V _{CC} = 3.0V; I _{OL} = 16mA		0.4	
		$V_{CC} = 3.0V; I_{OL} = 24mA$		0.55	

^{1.} These values of V_I are used to test DC electrical characteristics only. Functional test should use $V_{IH} \ge 2.4 \text{V}, V_{IL} \le 0.5 \text{V}.$

DC ELECTRICAL CHARACTERISTICS (continued)

			T _A = -40°C to +85°C		
Symbol	Characteristic	Condition	Min	Max	Unit
Ц	Input Leakage Current	$2.7V \le V_{CC} \le 3.6V; \ 0V \le V_{I} \le 5.5V$		±5.0	μΑ
loz	3-State Output Current	$2.7 \le V_{CC} \le 3.6V$; $0V \le V_{O} \le 5.5V$; $V_{I} = V_{IH}$ or V_{IL}		±5.0	μА
lOFF	Power-Off Leakage Current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 5.5V$		10	μΑ
Icc	Quiescent Supply Current	$2.7 \le V_{CC} \le 3.6V$; $V_I = GND$ or V_{CC}		10	μΑ
		$2.7 \le V_{CC} \le 3.6V$; $3.6 \le V_I$ or $V_O \le 5.5V$		±10	μΑ
Δlcc	Increase in I _{CC} per Input	$2.7 \le V_{CC} \le 3.6V; V_{IH} = V_{CC} - 0.6V$		500	μΑ

AC CHARACTERISTICS¹ ($t_R = t_F = 2.5$ ns; $C_L = 50$ pF; $R_L = 500\Omega$)

			Limits T						
					1				
			V _{CC} = 3.0	OV to 3.6V	V _{CC} :	= 2.7V	1		
Symbol	Parameter	Waveform	Min	Max	Min	Max	Unit		
tPLH tPHL	Propagation Delay An to Bn or Bn to An	1	1.5 1.5	7.0 7.0	1.5 1.5	8.0 8.0	ns		
tPLH tPHL	Propagation Delay LEBA to An or LEAB to Bn	4	1.5 1.5	8.5 8.5	1.5 1.5	9.5 9.5	ns		
tPZH tPZL	Output Enable Time OEBA to An or OEAB to Bn	2	1.5 1.5	9.0 9.0	1.5 1.5	10.0 10.0	ns		
tPHZ tPLZ	Output Disable Time OEBA to An or OEAB to Bn	2	1.5 1.5	7.0 7.0	1.5 1.5	7.5 7.5	ns		
^t PZH ^t PZL	Output Enable Time EBA to An or EAB to Bn	2	1.5 1.5	9.0 9.0	1.5 1.5	10.0 10.0	ns		
tPHZ tPLZ	Output Disable Time EBA to An or EAB to Bn	2	1.5 1.5	7.0 7.0	1.5 1.5	7.5 7.5	ns		
t _S	Setup Time, HIGH to LOW Data to LExx	4	2.5		2.5		ns		
t _h	Hold Time, HIGH to LOW Data to LExx	4	1.5		1.5		ns		
t _S	Setup Time, HIGH to LOW Data to Exx	4	2.5		2.5		ns		
t _h	Hold Time, HIGH to LOW Data to Exx	4	1.5		1.5		ns		
t _W	Latch Enable or Enable Pulse Width, LOW	4	3.3		3.3		ns		
toshl toslh	Output-to-Output Skew (Note 2)			1.0 1.0			ns		

^{1.} These AC parameters are preliminary and may be modified prior to release. The maximum AC limits are design targets. Actual performance will be specified upon completion of characterization.

DYNAMIC SWITCHING CHARACTERISTICS

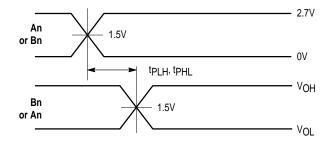
			T _A = +25°C			
Symbol	Characteristic	Condition	Min	Тур	Max	Unit
VOLP	Dynamic LOW Peak Voltage ¹	$V_{CC} = 3.3V$, $C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$		0.8		V
V _{OLV}	Dynamic LOW Valley Voltage ¹	$V_{CC} = 3.3V$, $C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$		0.8		V

^{1.} Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device.
 The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}); parameter guaranteed by design.

CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Condition	Typical	Unit
C _{PD}	Power Dissipation Capacitance	10MHz, $V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC}	25	pF
C _{IN}	Input Capacitance	$V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC}	7	pF
C _{I/O}	Input/Output Capacitance	$V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC}	8	pF



WAVEFORM 1 – A/B to B/A PROPAGATION DELAYS $t_R = t_F = 2.5 ns$, 10% to 90%; f = 1MHz; $t_W = 500 ns$

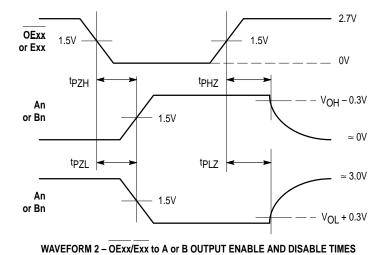
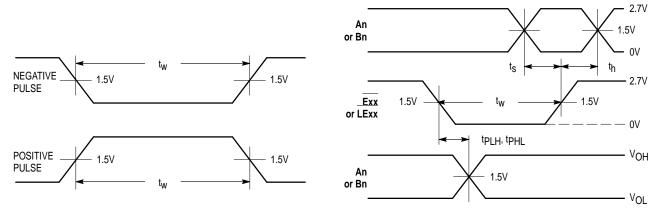


Figure 1. AC Waveforms

5

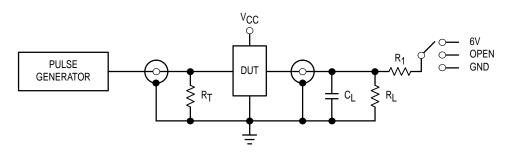
 $t_R = t_F = 2.5$ ns, 10% to 90%; f = 1MHz; $t_W = 500$ ns



WAVEFORM 3 – INPUT PULSE DEFINITION $t_R = t_F = 2.5$ ns, 10% to 90% of 0V to 2.7V

WAVEFORM 4 - Enable to A or B PROPAGATION DELAYS, Enable MINIMUM PULSE WIDTH, A or B to Enable SETUP AND HOLD TIMES $t_R = t_F = 2.5 \, \text{ns}$, 10% to 90%; $f = 1 \, \text{MHz}$; $t_W = 500 \, \text{ns}$ except when noted

Figure 2. AC Waveforms (continued)

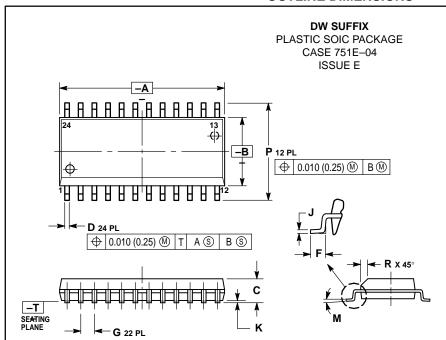


TEST	SWITCH
^t PLH ^{, t} PHL	Open
tPZL, tPLZ	6V
Open Collector/Drain tpLH and tpHL	6V
^t PZH ^{, t} PHZ	GND

 C_L = 50pF or equivalent (Includes jig and probe capacitance) R_L = R_1 = 500 Ω or equivalent R_T = Z_{OUT} of pulse generator (typically 50 Ω)

Figure 3. Test Circuit

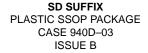
OUTLINE DIMENSIONS



NOTES:

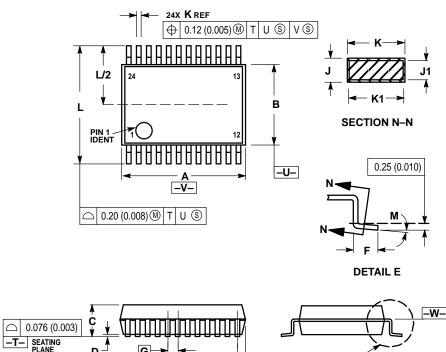
- DIMENSIONING AND TOLERANCING PER ANSI Y14 5M 1982
- CONTROLLING DIMENSION: MILLIMETER.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.13 (0.005) TOTAL IN EXCESS OF D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	15.25	15.54	0.601	0.612
В	7.40	7.60	0.292	0.299
С	2.35	2.65	0.093	0.104
D	0.35	0.49	0.014	0.019
F	0.41	0.90	0.016	0.035
G	1.27	BSC	0.050	BSC
J	0.23	0.32	0.009	0.013
K	0.13	0.29	0.005	0.011
M	0°	8°	0°	8°
Р	10.05	10.55	0.395	0.415
R	0.25	0.75	0.010	0.029



DETAIL E

7



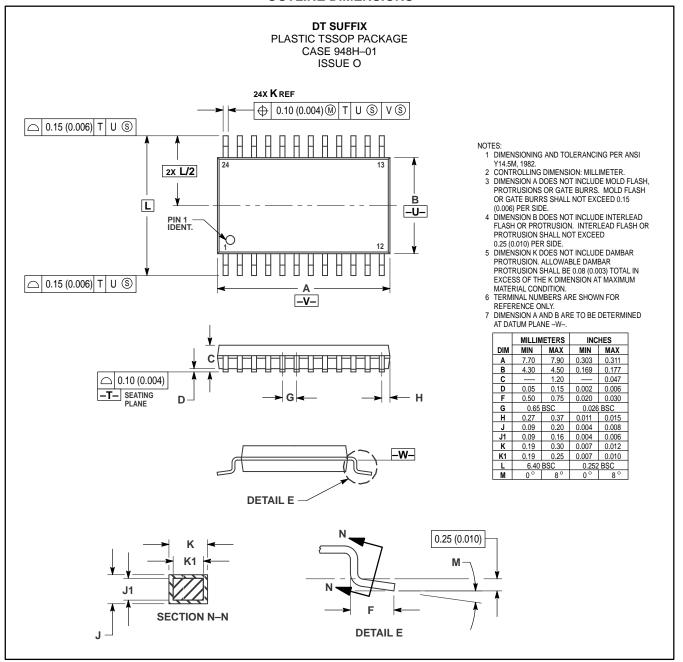
н

- NOTES:
 4 DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982.
 5 CONTROLLING DIMENSION: MILLIMETER.
- 6 DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 7 DIMENSION B DOES NOT INCLUDE INTERLEAD
- FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.15 (0.006) PER SIDE.

 8 DIMENSION K DOES NOT INCLUDE DAMBAR
- DIMENSION R DOES NOT INCLUDE DAMBAR
 PROTRUSION/INTRUSION. ALLOWABLE DAMBAR
 PROTRUSION SHALL BE 0.13 (0.005) TOTAL IN
 EXCESS OF K DIMENSION AT MAXIMUM
 MATERIAL CONDITION. DAMBAR INTRUSION SHALL NOT REDUCE DIMENSION K BY MORE THAN 0.07 (0.002) AT LEAST MATERIAL CONDITION.
- 9 TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. 10 DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	8.07	8.33	0.317	0.328
В	5.20	5.38	0.205	0.212
С	1.73	1.99	0.068	0.078
D	0.05	0.21	0.002	0.008
F	0.63	0.95	0.024	0.037
G	0.65	BSC	0.026	BSC
Н	0.44	0.60	0.017	0.024
J	0.09	0.20	0.003	0.008
J1	0.09	0.16	0.003	0.006
K	0.25	0.38	0.010	0.015
K1	0.25	0.33	0.010	0.013
L	7.65	7.90	0.301	0.311
M	0 °	8 °	0 °	8 °

OUTLINE DIMENSIONS



Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters can and do vary in different applications. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and

How to reach us:

USA/EUROPE: Motorola Literature Distribution; P.O. Box 20912; Phoenix, Arizona 85036. 1–800–441–2447

MFAX: RMFAX0@email.sps.mot.com -TOUCHTONE (602) 244-6609 INTERNET: http://Design-NET.com

JAPAN: Nippon Motorola Ltd.; Tatsumi–SPD–JLDC, Toshikatsu Otsuki, 6F Seibu–Butsuryu–Center, 3–14–2 Tatsumi Koto–Ku, Tokyo 135, Japan. 03–3521–8315

HONG KONG: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298



MC74LCX543/D